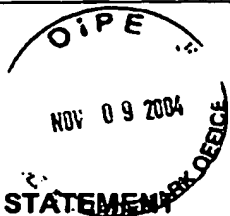


FORM PTO-1449 (modified)
To: U.S. Department of Commerce
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Atty. Dkt. No.	M#	Client Ref.
	0305303	T4YK-02S1556-1

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Applicant: YONEZAWA

Appln. No.: 10/629,894

Filing Date: July 30, 2003

Examiner: ~~Unknown~~ Group Art Unit: 2655

Date: November 9, 2004 Page 1 of 1

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Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
	BR					
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	DR					
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	FR					
	GR					
	HR					
	IR					
	JR					
	KR					
	LR					
	MR					
	NR					

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						Enclosed	No	Enclose	No
TD	OR	2001-126270	05/2001	JAPAN	Aizawa et al.	x			
↓	PR	2000-331353	11/2000	JAPAN	Ueki et al.	x			
	QR	10-134364	05/1998	JAPAN	Aoki	x			
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	WR								
	XR								

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

YR	Japanese Office Action for Japanese Patent Application No. 2002-224833, dated September 14, 2004.			
ZR				
AAR				
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	008312-0305303	T4YK-02S1556-1

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: Yonezawa
Appln. No.: 10/629,894
Filing Date: July 30, 2003
Examiner: ~~Unassigned~~ Group Art Unit: ~~2655~~

Date: July 25, 2005 Page 1 of 1

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Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
	AR					
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		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
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	WR								
	XR								

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)									
YR Chinese Office Action dated April 29, 2005 for Appln. No. 00152424.0									
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T4YK-02S1556-1

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: YONEZAWA, Minoru

Appln. No.: ~~UNASSIGNED~~ 10/629,894

Filing Date: July 30, 2003

Date: July 30, 2003

Page 1 of 1

Examiner: ~~UNKNOWN~~ Group Art Unit: ~~UNKNOWN~~

U.S. PATENT DOCUMENTS

2627

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
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	GR					
	HR					
	IR					
	JR					
	KR					
	LR					
	MR					
	NR					

FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
TD	OR	2000-251271	09/2000	Japan			X		X
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	RR								
	SR								
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